INTEGRATED CIRCUITS

DATA SHEET

74F280B9-bit odd/even parity generator/checker

Product specification

1996 Mar 12

IC15 Data Handbook





9-bit odd/even parity generator/checker

74F280B

FEATURES

- High-impedance NPN base inputs for reduced loading (20μA in Low and High states)
- Buffered inputs one normalized load
- Word length easily expanded by cascading
- Industrial temperature range available (-40°C to +85°C)

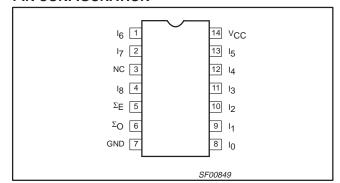
DESCRIPTION

The 74F280B is a 9-bit Parity Generator or Checker commonly used to detect errors in high speed data transmission or data retrieval systems. Both Even (Σ_{E}) and Odd (Σ_{O}) parity outputs are available for generating or checking even or odd parity on up to 9 bits.

The Even (Σ_E) parity output is High when an even number of Data inputs $(I_0 - I_8)$ are High. The Odd (Σ_O) parity output is High when an odd number of Data inputs are High.

Expansion to larger word sizes is accomplished by tying the Even (Σ_E) outputs of up to nine parallel devices to the data inputs of the final stage. This expansion scheme allows an 81-bit data word to be checked in less than 20ns.

PIN CONFIGURATION



| TYPE | TYPICAL PROPAGATION DELAY | TYPICAL SUPPLY CURRENT (TOTAL) |
|---------|---------------------------------|--------------------------------------|
| 74F280B | 5.5ns | 26mA |

ORDERING INFORMATION

| DESCRIPTION | COMMERCIAL RANGE V_{CC} = 5V $\pm 10\%$, T_{amb} = 0°C to +70°C | INDUSTRIAL RANGE V_{CC} = 5V $\pm 10\%$, T_{amb} = -40° C to $+85^{\circ}$ C | PKG. DWG. # |
|--------------------|--|--|-------------|
| 14-pin plastic DIP | N74F280BN | I74F280BN | SOT27-1 |
| 14-pin plastic SO | N74F280BD | I74F280BD | SOT108-1 |

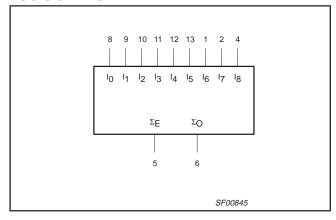
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

| PINS | DESCRIPTION | 74F(U.L.) HIGH/LOW | LOAD VALUE HIGH/LOW |
|---------------------------------|----------------|-----------------------|------------------------|
| I ₀ - I ₈ | Data inputs | 1.0/0.033 | 20μΑ/20μΑ |
| Σ_{E}, Σ_{O} | Parity outputs | 50/33 | 1.0mA/20mA |

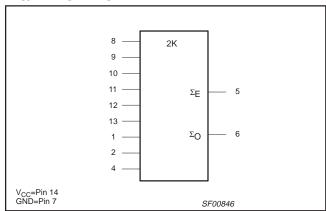
NOTE:

One (1.0) FAST Unit Load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC SYMBOL



IEC/IEEE SYMBOL

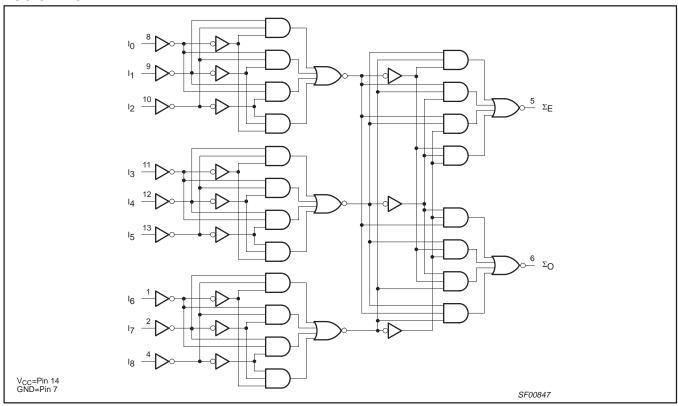


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LOGIC DIAGRAM



FUNCTION TABLE

| INPUTS | OUTPUTS | | | | |
|---|--------------|--------------|--|--|--|
| Number of High Data Inputs (I ₀ - I ₈) | Σ_{E} | Σ_{O} | | | |
| Even — 0, 2, 4, 6, 8 | Н | L | | | |
| Odd — 1, 3, 5, 7, 9 | L | Н | | | |

H = High voltage level
L = Low voltage level

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ABSOLUTE MAXIMUM RATINGS

| SYMBOL | PARAMETE | R | RATING | UNIT |
|------------------|--|-------------------------|--------------|------|
| V _{CC} | Supply voltage | | -0.5 to +7.0 | V |
| V _{IN} | Input voltage | | -0.5 to +7.0 | V |
| I _{IN} | Input current | −30 to +5 | mA | |
| V _{OUT} | Voltage applied to output in High output state | –0.5 to V _{CC} | V | |
| l _{OUT} | Current applied to output in Low output state | | 40 | mA |
| _ | Operation from air temperature range | Commercial range | 0 to +70 | °C |
| T _{amb} | Operating free-air temperature range | Industrial range | -40 to +85 | °C |
| T _{stg} | Storage temperature | -65 to +150 | °C | |

RECOMMENDED OPERATING CONDITIONS

| CVMDOL | PARAMETER | | | LIMITS | | UNIT |
|------------------|--------------------------------------|------------------|-----|--------|-----|------|
| SYMBOL | PARAMETER | | Min | Nom | Max | UNII |
| V _{CC} | Supply voltage | | 4.5 | 5.0 | 5.5 | V |
| V _{IH} | High-level input voltage | 2.0 | | | V | |
| V _{IL} | Low-level input voltage | | | 0.8 | V | |
| I _{IK} | Input clamp current | | | | -18 | mA |
| Іон | High-level output current | | | | -1 | mA |
| l _{OL} | Low-level output current | | | | 20 | mA |
| _ | Operating free air temperature range | Commercial range | 0 | | 70 | °C |
| T _{amb} | Operating free-air temperature range | -40 | | 85 | °C | |

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

| SYMBOL | PARAME | TED | TEST CONDITION | NIC1 | | LIMITS | | UNIT |
|---------------------------------------|---|------------------|------------------------------|---------------------|------------------|--------|------|------|
| STWIBOL | TANAME | ILK | TEST CONDITIO | MIN | TYP ² | MAX | ONT | |
| V | High level output voltage | | $V_{CC} = MIN, V_{IL} = MAX$ | ±10%V _{CC} | 2.5 | | | ٧ |
| V _{OH} | High-level output voltage | | $V_{IH} = MIN, I_{OH} = MAX$ | ±5%V _{CC} | 2.7 | 3.4 | | V |
| \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ | Lave laved autaut valtage | | $V_{CC} = MIN, V_{IL} = MAX$ | ±10%V _{CC} | | 0.35 | 0.50 | V |
| V _{OL} | Low-level output voltage | | $V_{IH} = MIN, I_{OL} = MAX$ | ±5%V _{CC} | | 0.35 | 0.50 | V |
| V _{IK} | Input clamp voltage | | $V_{CC} = MIN, I_I = I_{IK}$ | - | | -0.73 | -1.2 | V |
| I _I | Input current at maximum | n input voltage | $V_{CC} = 0.0V, V_I = 7.0V$ | | | | 100 | μΑ |
| | Lligh lovel input gurrent | Commercial range | V MAY V 27V | | | | 20 | μΑ |
| ¹ıH | High-level input current | Industrial range | $V_{CC} = MAX, V_I = 2.7V$ | | | | 40 | μΑ |
| I _{IL} | Low-level input current | | $V_{CC} = MAX, V_I = 0.5V$ | | | | -20 | μΑ |
| Ios | Short-circuit output current ³ | | V _{CC} = MAX | | -60 | | -150 | mA |
| I _{CC} | Supply current (total) | | V _{CC} = MAX | | | 26 | 35 | mA |

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^{1.} For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
 Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, IOS tests should be performed last.

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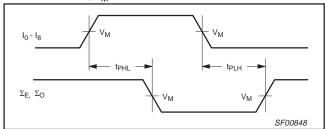
74F280B

AC ELECTRICAL CHARACTERISTICS

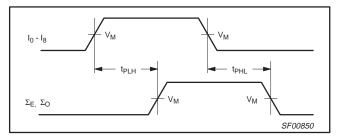
| | | | | | | | LII | MITS | | | |
|--------------------------------------|---|--------------------|---|------------|------------|--|------------|---|------------|--------------|----------|
| SYMBOL | PARAMETE | TEST CONDITIONS | T_{amb} = +25°C V_{CC} = +5.V C_L = 50pF, R_L = 500 Ω | | | T _{amb} = 0°C V _{CC} = +5 C _L = 5 R _L = | .V ± 10% | T _{amb} = -40° V _{CC} = +5 C _L = 9 R _L = | UNIT | | |
| | | | | Min | Тур | Max | Min | Max | Min | Max | |
| t _{PLH} t _{PHL} | Propagation delay $I_0 - I_8$ to Σ_E | 74F280B | Waveform 1, 2 | 4.0 4.0 | 6.5 7.0 | 9.0 10.0 | 3.5 3.5 | 10.0 11.1 | 3.0 3.5 | 11.0 12.0 | ns ns |
| t _{PLH} | Propagation delay $I_0 - I_8$ to Σ_0 | /4FZ0UB | Waveform 1, 2 | 4.0 4.0 | 6.5 7.0 | 9.0 10.0 | 3.5 3.5 | 10.0 11.0 | 3.0 3.5 | 11.0 12.0 | ns ns |

AC WAVEFORMS

For all waveforms, $V_M=1.5V$.

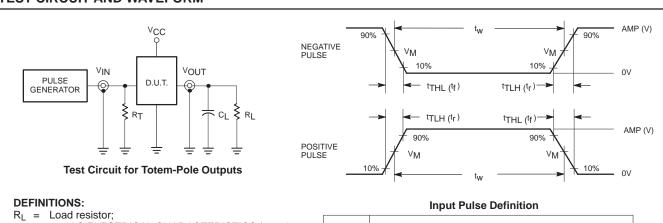


Waveform 1. Propagation Delay for Inverting Outputs



Waveform 2. Propagation Delay for Non-Inverting Outputs

TEST CIRCUIT AND WAVEFORM



see AC ELECTRICAL CHARACTERISTICS for value.

CL = Load capacitance includes jig and probe capacitance;

see AC ELECTRICAL CHARACTERISTICS for value.

RT = Termination resistance should be equal to Z_{OUT} of pulse generators.

| family | INP | INPUT PULSE REQUIREMENTS | | | | | | | | | | | |
|--------|-----------|--------------------------|-----------|----------------|------------------|------------------|--|--|--|--|--|--|--|
| | amplitude | V _M | rep. rate | t _w | t _{TLH} | t _{THL} | | | | | | | |
| 74F | 3.0V 1.5 | | 1MHz | 500ns | 2.5ns | 2.5ns | | | | | | | |

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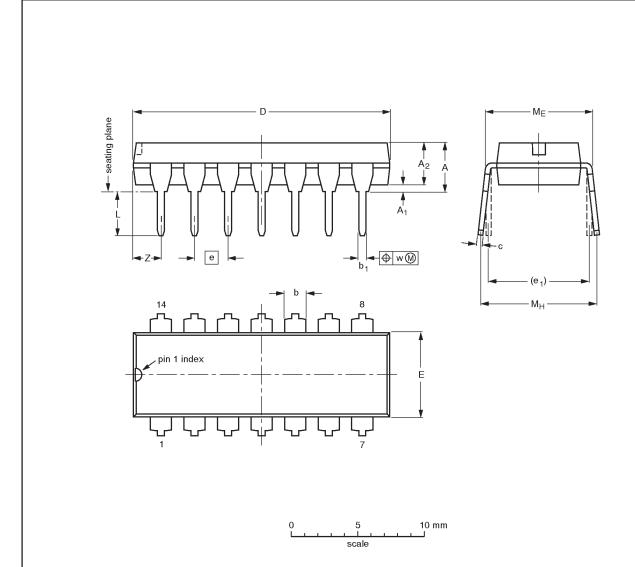
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DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

| UNIT | A max. | A ₁ min. | A ₂ max. | b | b ₁ | С | D ⁽¹⁾ | E ⁽¹⁾ | е | e ₁ | L | ME | M _H | w | Z ⁽¹⁾ max. |
|--------|-----------|------------------------|------------------------|----------------|----------------|----------------|------------------|------------------|------|----------------|--------------|--------------|----------------|-------|--------------------------|
| mm | 4.2 | 0.51 | 3.2 | 1.73 1.13 | 0.53 0.38 | 0.36 0.23 | 19.50 18.55 | 6.48 6.20 | 2.54 | 7.62 | 3.60 3.05 | 8.25 7.80 | 10.0 8.3 | 0.254 | 2.2 |
| inches | 0.17 | 0.020 | 0.13 | 0.068 0.044 | 0.021 0.015 | 0.014 0.009 | 0.77 0.73 | 0.26 0.24 | 0.10 | 0.30 | 0.14 0.12 | 0.32 0.31 | 0.39 0.33 | 0.01 | 0.087 |

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE | | REFER | RENCES | EUROPEAN | ISSUE DATE | |
|---------|--------|----------|--------|------------|---------------------------------|--|
| VERSION | IEC | JEDEC | EIAJ | PROJECTION | ISSUE DATE | |
| SOT27-1 | 050G04 | MO-001AA | | | 92-11-17 95-03-11 | |

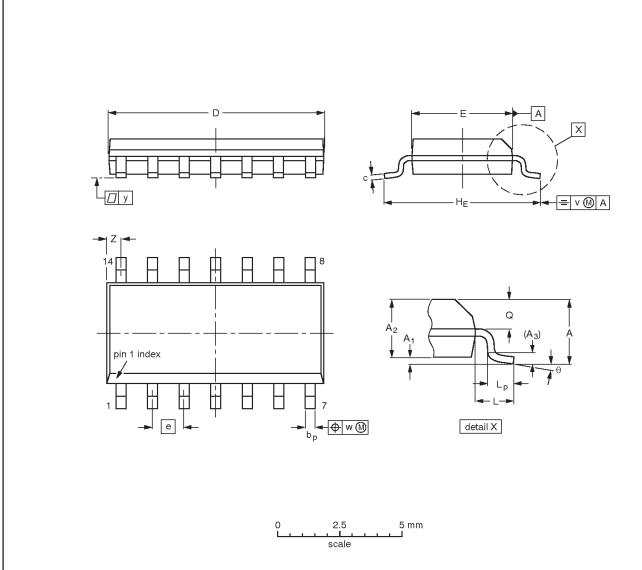
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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

| UNIT | A max. | A ₁ | A ₂ | А3 | bp | С | D ⁽¹⁾ | E ⁽¹⁾ | е | HE | L | Lp | Q | v | w | у | Z ⁽¹⁾ | θ |
|--------|-----------|----------------|----------------|------|--------------|------------------|------------------|------------------|-------|----------------|-------|----------------|----------------|------|------|-------|------------------|----|
| mm | 1.75 | 0.25 0.10 | 1.45 1.25 | 0.25 | 0.49 0.36 | 0.25 0.19 | 8.75 8.55 | 4.0 3.8 | 1.27 | 6.2 5.8 | 1.05 | 1.0 0.4 | 0.7 0.6 | 0.25 | 0.25 | 0.1 | 0.7 0.3 | 8° |
| inches | 0.069 | 0.010 0.004 | 0.057 0.049 | 0.01 | | 0.0100 0.0075 | | 0.16 0.15 | 0.050 | 0.244 0.228 | 0.041 | 0.039 0.016 | 0.028 0.024 | 0.01 | 0.01 | 0.004 | 0.028 0.012 | 0° |

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

| OUTLINE | | REFER | RENCES | | EUROPEAN PROJECTION | ISSUE DATE |
|----------|---------|----------|--------|--|------------------------|-----------------------------------|
| VERSION | IEC | JEDEC | EIAJ | | | 1990E DATE |
| SOT108-1 | 076E06S | MS-012AB | | | | -95-01-23- 97-05-22 |

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Data sheet status

| Data sheet status | Product status | Definition [1] | |
|---------------------------|-------------------|--|--|
| Objective specification | Development | This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice. | |
| Preliminary specification | Qualification | This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product. | |
| Product specification | Production | This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible produc | |

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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